

Notice of References Cited	Application/Control No. 10/582,332		Applicant(s)/Patent Under Reexamination KURITA ET AL.	
	Examiner Huan H. Tran		Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,595,895	09-2009	Kurita et al.	356/614
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	WO 2005/056229	06-2005	WPO	Kurita et al.	B23K26/06
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	U	International Preliminary Search Report in PCT/JP04/016340 dated 24 July 2006.
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.